Se	arcn	notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/649,198	KOUGIOURIS ET AL.	
Examiner	Art Unit	
Maikhanh Nguven	2176	

SEARCHED			
Class	Subclass	Date	Examiner
715	513	8/20/2005	мк
	526,531	8/20/2005	MK
715	700,760	8/20/2005	MK
	861	8/20/2005	МК
709	203	8/20/2005	MK
Updated	Search	4/27/2006	MK

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Inventor Name Search	8/20/2005	МК
West Search (See search history printout)	8/20/2005	МК
NPL (IEEE)	8/20/2005	МК
NPL (IEEE)	4/27/2006	МК
West Updated (USPAT, PG-PUB, EPO, JPO, DERWENT, IBM_TDB	4/27/2006	MK